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<p>(54) Title: IMAGE PROCESSING METHOD FOR THE REMOVAL OF SPOT DEFECTS AND APPARATUS THEREFOR</p>		
<p>(57) Abstract</p> <p>A method for processing an image for the removal of spot defects comprising scanning and sampling the image to generate an array of pixel image values and constructing a corresponding array of pixel image values for the processed image by carrying out the following steps: (a) examining the image values of each pixel of a predetermined subset of pixels in a block surrounding a central pixel thereby determining the image value corresponding to the highest and lowest values in said predetermined subset of said block (A_{high} and A_{low} respectively), (b) determining the image value corresponding to the central pixel of said block (A_{centre}), (c) calculating either the ratio: $R_1 = (A_{\text{low}} - A_{\text{centre}}) / (A_{\text{high}} - A_{\text{low}})$ or the ratio $R_2 = (A_{\text{centre}} - A_{\text{high}}) / (A_{\text{high}} - A_{\text{low}})$, (d) if the ratio is positive and its value is above a predetermined threshold value, writing an average value calculated on image values in the block to the element of the processed image array corresponding to said central pixel or, if not, writing the existing value (A_{centre}) to said element, and (e) repeating steps (a) to (d) until every pixel has been processed as the central pixel.</p>		

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IMAGE PROCESSING METHOD FOR THE REMOVAL OF SPOT DEFECTS
AND APPARATUS THEREFOR

The present invention relates to image
5 processing methods and apparatus for removing spot
defects from an image reconstructed from processed
image signals generated by scanning and sampling an
original image.

Such a process takes the form of dividing up
10 the original image into image elements or "pixels",
generating an array of image values representative of
the content of these pixels, processing these pixel
image values so as to remove or reduce unwanted
components therein and constructing an array of pixel
15 image values corresponding to the desired processed
image.

Images, in particular those scanned and
displayed electronically, may be degraded by several
forms of noise, including:

20 (1) Broadband noise affecting all pixels,
for example photographic grain. A variety of image
processing techniques have been proposed using
filtering and transform methods for the suppression of
broadband noise, e.g. in US Patent 4,442,454 or
25 copending application No.

(2) Noise consisting of randomly distributed
modifications of image values corresponding to single
or small groups of pixels. Such an effect has been
referred to as "salt and pepper" noise because it may
30 consist of random white and/or black spots. These may
arise at various stages, including:

- (a) in the formation of the original image,
- (b) during image sampling, or
- (c) in image data handling.

35 Methods to detect and remove isolated spot
defects are described in Rosenfeld, A. and Kak, A.C.,
"Digital Picture Processing", Academic Press, 1976,
and Pratt, W.K., "Digital Image Processing", Wiley,
1978. These procedures calculate the difference

between the central pixel value and either the mean or the extreme of its neighbourhood pixels. The central pixel is replaced by a local average value if the difference exceeds an absolute threshold.

5 Such a technique inevitably results in loss of overall sharpness of the image as a large amount of high frequency information is lost especially in cases where the nature of the image and the spot defects necessitate the use of a low threshold.

10 The present invention provides a method which removes unwanted spot defects without unduly affecting overall sharpness for images even in cases in which the spot defects have image values less than the maximum or greater than the minimum values.

15 According to the present invention there is provided a method for processing an image for the removal of spot defects comprising scanning and sampling the image to generate an array of pixel image values and constructing a corresponding array of pixel image values for the processed image by carrying out
20 the following steps:

(a) examining the image values of each pixel of a predetermined subset of pixels in a block surrounding a central pixel thereby determining the image value
25 corresponding to the highest and lowest values in said predetermined subset of said block (A_{high} and A_{low} respectively),

(b) determining the image value corresponding to
30 the central pixel of said block (A_{centre}),

(c) calculating either the ratio:

$$35 \quad R_1 = \frac{A_{\text{low}} - A_{\text{centre}}}{A_{\text{high}} - A_{\text{low}}}$$

or the ratio

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$$R_2 = \frac{A_{\text{centre}} - A_{\text{high}}}{A_{\text{high}} - A_{\text{low}}}$$

(d) if the ratio is positive and its value is above a predetermined threshold value, writing an average value
 5 calculated on image values in the block to the element of the processed image array corresponding to said central pixel or, if not, writing the existing value (A_{centre}) to said element, and

(e) repeating steps (a) to (d) until every pixel has
 10 been processed as the central pixel.

By using the value R_1 in step (c) low image value spot defects will be corrected. Alternatively by using R_2 high image value spots will be corrected. If both R_1 and R_2 are calculated in step (c) and the
 15 corrected value is written to the processed image array if either of R_1 and R_2 is positive and above the threshold value both types of defect will be corrected. Only one of them, of course, can be positive for each block location.

20 It is preferred that the predetermined subset of pixels of step (a) comprises all the pixels lying on the periphery of the block. In a (3 x 3) pixel block there are, of course, 8 peripheral pixels and one central one; however in a larger block, such as a (5 x 5) pixel block,
 25 there are 16 peripheral pixels, one central pixel and eight intermediate ones. It might sometimes be desirable to take account of these intermediate pixels.

The average value referred to in step (d) may be obtained by calculating the median or the arithmetic mean
 30 of all the pixel image values in the block except for the central pixel. Alternatively less than all the possible pixel image values could be used, eg just the peripheral ones, or a system of weighting these values could be employed.

35 The simplest way to implement the present method is by comparison of the value of each central pixel with the eight pixels values in the immediate (3 x 3)

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neighbourhood, of which the value of the smallest, $A(1)$, and the largest, $A(8)$, are noted. In this case the neighbourhood range, $A_{\text{high}} - A_{\text{low}}$, is determined by the difference between these two values,

$$\text{Range} = A(8) - A(1).$$

Similarly, the central-neighbourhood difference is, in this case:

$$A(1) - A_{\text{centre}} \quad (\text{for the calculation of } R_1)$$

or

$$A_{\text{centre}} - A(8) \quad (\text{for the calculation of } R_2).$$

If the difference is zero or has a negative value, then the central pixel is assumed not to be a defect, its value is unchanged, and the process is repeated for the next pixel.

Otherwise the ratio R_1 or R_2 is calculated. If the value of the ratio is above the predetermined value, the value of the corresponding pixel in the processed image array is set to an average value calculated on the image values in the block. At its simplest this value is the median or, preferably, the arithmetic mean of the eight peripheral image values in the block. The pixel value remains unchanged if the ratio is below the level of the threshold: it is assumed to represent either image detail or broadband noise.

The predetermined threshold is dependent on the image and defect characteristics, and is optimised to remove the maximum number of spot defects whilst having the minimum effect on image information. Experiment indicates that the threshold may be set to a very small value before perceptibly degrading the image. A suitable ratio threshold for a typical photographic image is around 0.25 when the pixel block is (5 x 5) and the predetermined subset comprises the peripheral pixels. It is to be understood however that the actual value adopted will depend upon the sharpness of the original image.

An algorithm which employs a (3 x 3) neighbourhood is unable to detect any spot defects other than single pixels. Experiment indicates that some spot

defects are larger than single pixels hence are not detected, and so remain in the resultant images.

An improvement is achieved by the use of the sixteen perimeter pixels of a (5 x 5) block as the comparison subset, which will permit the detection of a larger spot defect within the perimeter. There is a chance, however, that other spot defects may overlap the (5 x 5) perimeter itself, which will reduce the chance of detecting the central spot. This problem can be reduced by writing each corrected central pixel image value back into the original array and not using a separate array to record the processed image values. Subsequent steps will then use the corrected values already determined by the processing in earlier steps. The effect of this is to increase the efficiency of spot defect removal considerably with no visible detriment to the picture information.

The performance can be also be improved in two further ways. The first is to ignore the most extreme or the two most extreme image values of the smallest or largest pixel image values of the predetermined subset of each block when calculating R_1 or R_2 respectively. For example, if the subset represents the 16 peripheral pixels of a (5 x 5) block and the method is being carried out to reduce only low image value spot defects, the ratio R_1 will become:

$$R_1 = \frac{A(3) - A_{\text{centre}}}{A(16) - A(3)}$$

where, as before, $A(1)$ to $A(16)$ are ranked in image value, $A(16)$ being the highest. If the method is being carried out to reduce only high image value spot defects, the ratio R_2 will become:

$$R_2 = \frac{A_{\text{centre}} - A(14)}{A(14) - A(1)}$$

This will reduce the interference on the removal of spots by the remaining defects, and also by any image detail information that may lie in the neighbourhood. In the case of the (5 x 5) block the exclusion of only the most extreme pixel value from the operation leaves many defects undetected, whilst excluding the three most extreme pixel values visibly reduces the image sharpness to a small degree.

Secondly, it is possible to further reduce the interference of picture detail on spot removal, although not to eliminate it, by operating the algorithm only on the high-frequency content of the image. The effect of high-pass filtering is to leave the amplitude of single pixel and small area defects almost unchanged, while considerably reducing the amplitude of low-frequency fluctuations within the neighbourhood. If a spot is detected in the high-pass image the pixel value is set to zero: this corresponds to replacing the value in the full bandwidth image with a weighted average of the image values of all the pixels in the neighbourhood.

It is possible to apply the spot defect removal algorithm to image data either before or after broadband noise suppression. However, the reduction of noise fluctuations in the area of the neighbourhood due to the noise suppression algorithm described in US Patent 4,442,454 permits the present defect removal algorithm to operate most efficiently if noise suppression is performed first.

The present invention also provides an apparatus comprising means for sampling the brightness of an image at a regular array of locations and providing an orderly sequence of pixel image values as input to means for processing said values according to the method of the present invention and generating a sequence of modified pixel image values that correspond to sampled brightness values of the processed image.

CLAIMS

1. A method for processing an image for the removal of spot defects comprising scanning and sampling the image to generate an array of pixel image values and constructing a corresponding array of pixel image values for the processed image by carrying out the following steps:

(a) examining the image values of each pixel of a predetermined subset of pixels in a block surrounding a central pixel thereby determining the image value corresponding to the highest and lowest values in said predetermined subset of said block (A_{high} and A_{low} respectively),

(b) determining the image value corresponding to the central pixel of said block (A_{centre}),

(c) calculating either the ratio:

$$R_1 = \frac{A_{\text{low}} - A_{\text{centre}}}{A_{\text{high}} - A_{\text{low}}}$$

or the ratio

$$R_2 = \frac{A_{\text{centre}} - A_{\text{high}}}{A_{\text{high}} - A_{\text{low}}}$$

(d) if the ratio is positive and its value is above a predetermined threshold value, writing an average value calculated on image values in the block to the element of the processed image array corresponding to said central pixel or, if not, writing the existing value (A_{centre}) to said element, and

(e) repeating steps (a) to (d) until every pixel has been processed as the central pixel.

2. A method as claimed in claim 1 in which both R_1 and R_2 are calculated in step (c) and in which the corrected value is written to the processed image array if either of R_1 and R_2 is positive and above the threshold value.

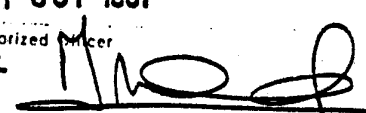
3. A method as claimed in claim 1 or 2 wherein the size of the block is (3 x 3) or (5 x 5) pixels.

4. A method as claimed in any of claims 1 to 3 wherein the predetermined subset of pixels of step (a) comprises the peripheral pixels of the block.
- 5 5. A method as claimed in any of claims 1 to 4 in which the average value of step (d) is the arithmetic mean of the pixel image values of the predetermined subset.
- 10 6. A method as claimed any of claims 1 to 5 wherein there is no separate processed image array and the corrected image values are written back to the original image array and subsequent processing utilises any already corrected image value.
- 15 7. A method as claimed in any of claims 1 to 5 wherein the most extreme or the two most extreme smallest or largest image values of each predetermined subset of pixels in the block are ignored when calculating R_1 or R_2 respectively.
- 20 8. A method as claimed in any of claims 1 to 7 in which the processing is performed on a high pass version of the original signal which, after said processing, is recombined with the complimentary low pass version.
- 25 9. An apparatus comprising means for sampling brightness of an image at a regular array of locations and providing an orderly sequence of image signal values as input to means for processing said values according to the method of any of Claims 1 to 6 and generating a sequence of
30 modified image signal values that correspond to sampled brightness values of the processed image.
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INTERNATIONAL SEARCH REPORT

International Application No **PCT/GB 87/00404**

I. CLASSIFICATION OF SUBJECT MATTER (if several classification symbols apply, indicate all) *		
According to International Patent Classification (IPC) or to both National Classification and IPC		
IPC ⁴ : G 06 F 15/68		
II. FIELDS SEARCHED		
Minimum Documentation Searched ⁷		
Classification System	Classification Symbols	
IPC ⁴	G 06 F 15/68	
Documentation Searched other than Minimum Documentation to the Extent that such Documents are Included in the Fields Searched *		
III. DOCUMENTS CONSIDERED TO BE RELEVANT ⁸		
Category ⁹	Citation of Document, ¹¹ with indication, where appropriate, of the relevant passages ¹²	Relevant to Claim No. ¹³
A	Optical Engineering, volume 22, no. 3, May/June 1983, (Bellingham, WA, US), J.D. Fahnestock et al.: "Spatially variant contrast enhancement using local range modification", pages 378-381 see the whole document	1, 6, 9
A	US, A, 4541116 (R.M. LOUGHEED) 10 September 1985 see column 7; claim 1	1
A	Computer Vision, Graphics and Image Processing, volume 24, no. 2, November 1983, Academic Press, Inc., (New York, US), J.S. Lee: "Digital image smoothing and the Sigma filter", pages 255-269 see page 259, line 11 - page 260, line 19; page 263, line 1 - page 265, line 3	1, 3

<p>* Special categories of cited documents: ¹⁰</p> <p>"A" document defining the general state of the art which is not considered to be of particular relevance</p> <p>"E" earlier document but published on or after the international filing date</p> <p>"L" document which may throw doubt on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)</p> <p>"O" document referring to an oral disclosure, use, exhibition or other means</p> <p>"P" document published prior to the international filing date but later than the priority date claimed</p> <p>"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention</p> <p>"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step</p> <p>"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art.</p> <p>"&" document member of the same patent family</p>		
IV. CERTIFICATION		
Date of the Actual Completion of the International Search	Date of Mailing of this International Search Report	
1st October 1987	21 OCT 1987	
International Searching Authority	Signature of Authorized Officer	
EUROPEAN PATENT OFFICE	M. VAN MOL 	

ANNEX TO THE INTERNATIONAL SEARCH REPORT ON

INTERNATIONAL APPLICATION NO. PCT/GB 87/00404 (SA 17473)

This Annex lists the patent family members relating to the patent documents cited in the above-mentioned international search report. The members are as contained in the European Patent Office EDP file on 09/10/87

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Patent document cited in search report	Publication date	Patent family member(s)	Publication date
US-A- 4541116	10/09/85	None	

For more details about this annex :
see Official Journal of the European Patent Office, No. 12/82